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## IN THE CLAIMS:

Please amend the claims as follows:

1. (Currently Amended) A microfabrication process for fabricating a microelectromechanical systems device, comprising:

depositing one or a stack of layers on a substrate;

patterning said one or a stack of layers to form a plurality of longitudinally extending

groves therein;

depositing a middle layer on said one or a stack of layers; and

patterning the middle layer using said one or a stack of layers as a photomask[[.]],

wherein said middle layer is exposed to light passed through the groves in the one or a stack

of layers; and

developing said middle layer to form longitudinally spaced ridges in the said middle layer disposed in the groves in said one or a stack of layers, said ridges forming a support structure which is part of the microelectromechanical systems device.

- 2. (Original) The method of claim 1, wherein the substrate permits light to pass therethrough.
- 3. (Original) The method of claim 2, wherein the substrate comprises glass.

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4. Canceled.

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5. Canceled.

6. (Currently Amended) The method of claim 1, further comprising depositing a top

layer over said middle layer.

7. (Original) The method of claim 1, wherein said one or an uppermost layer of said

stack of layers is a sacrificial layer.

8. (Original) The method of claim 1, wherein the said middle layer comprises a

negative- acting-photosensitive material.

9. (Original) The method of claim 6, wherein said top layer comprises nickel and

aluminum.

10. (Original) The method of claim 6, further comprising patterning said top layer.

11. Canceled.

12. (Currently Amended) The method of claim [[11]]10, wherein said top layer is

patterned to define transversely extending strips which are supported by the longitudinally

spaced ridges in the said middle layer.

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AMENDMENT AND RESPONSE TO OFFICE ACTION

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13. (Currently Amended) A method for fabricating a microelectromechanical systems

device, the method of comprising:

a) depositing one or a stack of layers on a base layer, said one layer or an

uppermost layer in said stack of layers being a sacrificial layer;

b) patterning said one or a stack of layers to provide at least one aperture

therethrough through which said base layer is exposed;

c) depositing a photosensitive layer over said one or a stack of layers; and

passing light through said at least one aperture to expose said photosensitive

layer[[.]]; and

d)

e) developing said one or a stack of layers to remove unexposed portions of said

photosensitive layer and said sacrificial layer to form at least one mechanical support, each

support being defined by a portion of said photosensitive layer exposed through an aperture.

14. (Original) The method of claim 13, wherein the base layer is a substrate layer.

15. (Original) The method of claim 13, wherein said light comprises ultraviolet light.

16. (Original) The method of claim 13, wherein said photosensitive layer comprises a

negative-acting-photosensitive material.

17. (Original) The method of claim 13, further comprising depositing a structural layer

over said photosensitive layer.

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- 18. Canceled.
- 19. (Currently Amended) The method of claim [[18]]17, wherein said steps (a) to (d)(e) are repeated at least once, wherein for each repetition, each the structural layer defines forms the base layer.

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